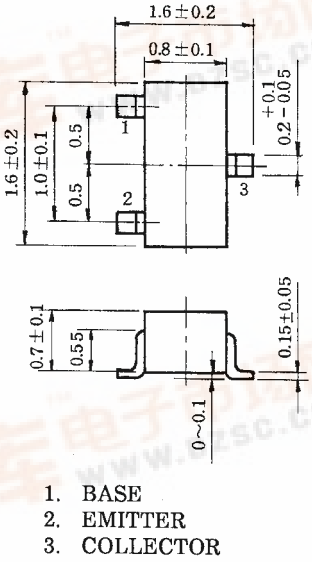
TOSHIBA Transistor Silicon PNP Epitaxial Type (PCT Process)

RN2110,RN2111

Switching, Inverter Circuit, Interface Circuit and Driver Circuit Applications

- With built-in bias resistors
- Simplify circuit design
- Reduce a quantity of parts and manufacturing process
- Complementary to RN1110, RN1111

Unit: mm

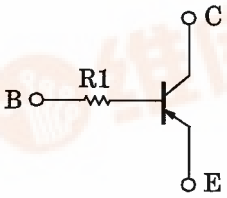


1. BASE
2. EMITTER
3. COLLECTOR

JEDEC	—
EIAJ	—
TOSHIBA	2−2H1A

Weight: 2.4mg

Equivalent Circuit



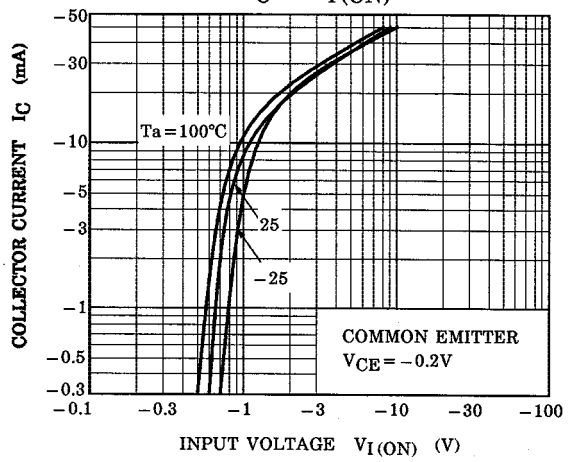
Maximum Ratings (Ta = 25°C)

Characteristic	Symbol	Rating	Unit
Collector-base voltage	V_{CBO}	−50	V
Collector-emitter voltage	V_{CEO}	−50	V
Emitter-base voltage	V_{EBO}	−5	V
Collector current	I_C	−100	mA
Collector power dissipation	P_C	100	mW
Junction temperature	T_j	150	°C
Storage temperature range	T_{stg}	−55~150	°C

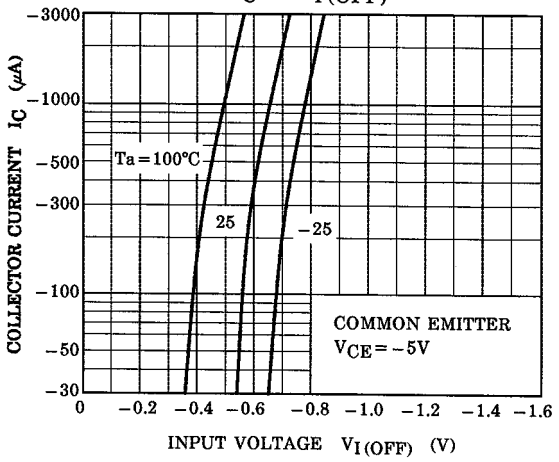
Electrical Characteristics (Ta = 25°C)

Characteristic		Symbol	Test Circuit	Test Condition	Min	Typ.	Max	Unit
Collector cut-off current		I_{CBO}	—	V_{CB} = −50V, I_E = 0	—	—	−100	nA
Emitter cut-off current		I_{EBO}	—	V_{EB} = −5V, I_C = 0	—	—	−100	nA
DC current gain		h_{FE}	—	V_{CE} = −5V, I_C = −1mA	120	—	400	—
Collector-emitter saturation voltage		$V_{CE\ (sat)}$	—	I_C = −5mA, I_B = −0.25mA	—	−0.1	−0.3	V
Transition frequency		f_T	—	V_{CE} = −10V, I_C = −5mA	—	200	—	MH_z
Collector output capacitance		C_{ob}	—	V_{CB} = −10V, I_E = 0, f = $1MH_z$	—	3	6	pF
Input resistor	RN2110	R1	—	—	3.29	4.7	6.11	kΩ
	RN2111				7	10	13	

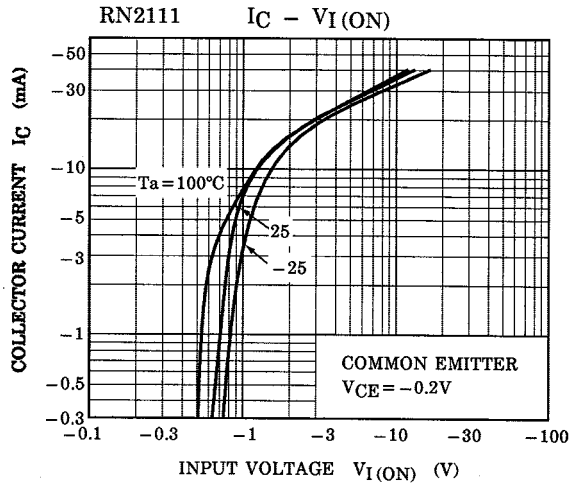
RN2110 $I_C - V_{I(ON)}$



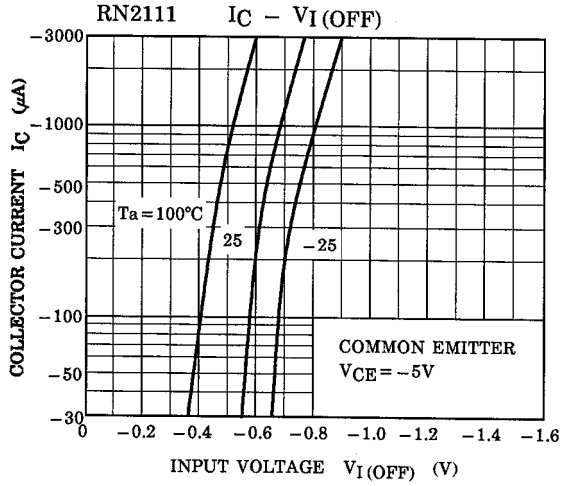
RN2110 $I_C - V_{I(OFF)}$



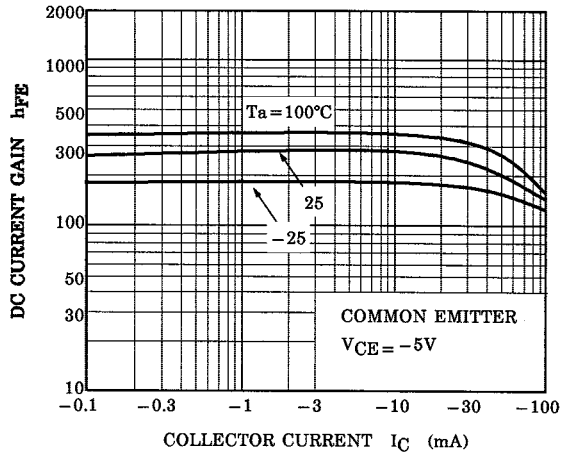
RN2111 $I_C - V_{I(ON)}$



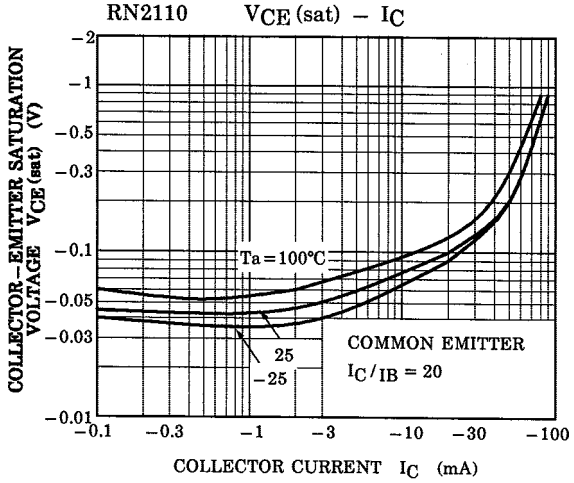
RN2111 $I_C - V_{I(OFF)}$



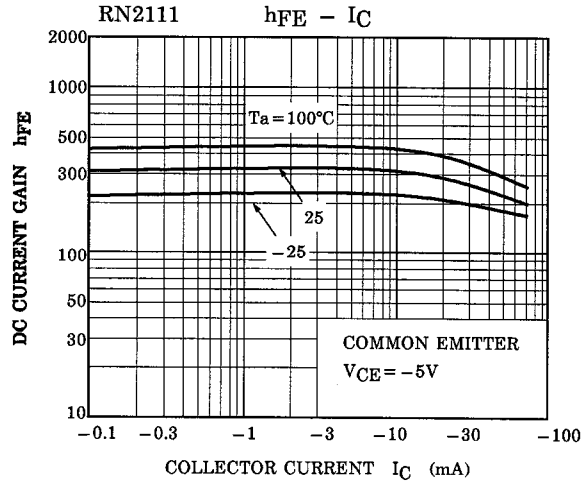
RN2110 h_{FE} – I_C



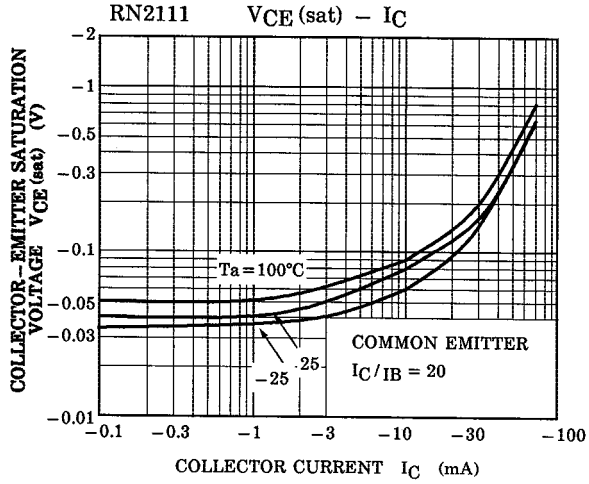
RN2110 V_{CE} (sat) – I_C

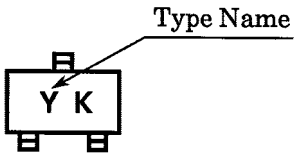
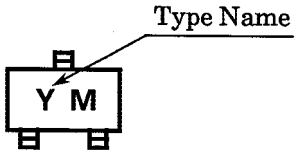


RN2111 h_{FE} – I_C



RN2111 V_{CE} (sat) – I_C



Type Name	Marking
RN2110	
RN2111	

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